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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants

Hideto Nakamura

Naoya Kurimoto

Appl. No.

10/695,464

Filed

October 28, 2003

For

CONNECTOR

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SECOND INFORMATION DISCLOSURE STATEMENT

Sir:

The above-identified U.S. patent application corresponds to European Appl. No. 03 024 976 7. A Search Report issued in connection with the European application on February 4, 2004. The European Searcher identified two U.S. references as being relevant. Those references have been listed on the attached copy of Form PTO-1449. The Examiner is urged to consider these references during the examination and to make

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the references of record.

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Respectfully submitted,

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Form PTO-A820 (also form PTO-1449)